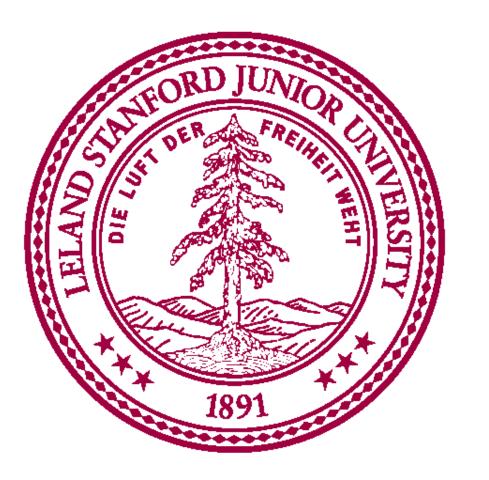
Electrothermal Modeling with Geant4 + COMSOL Integration



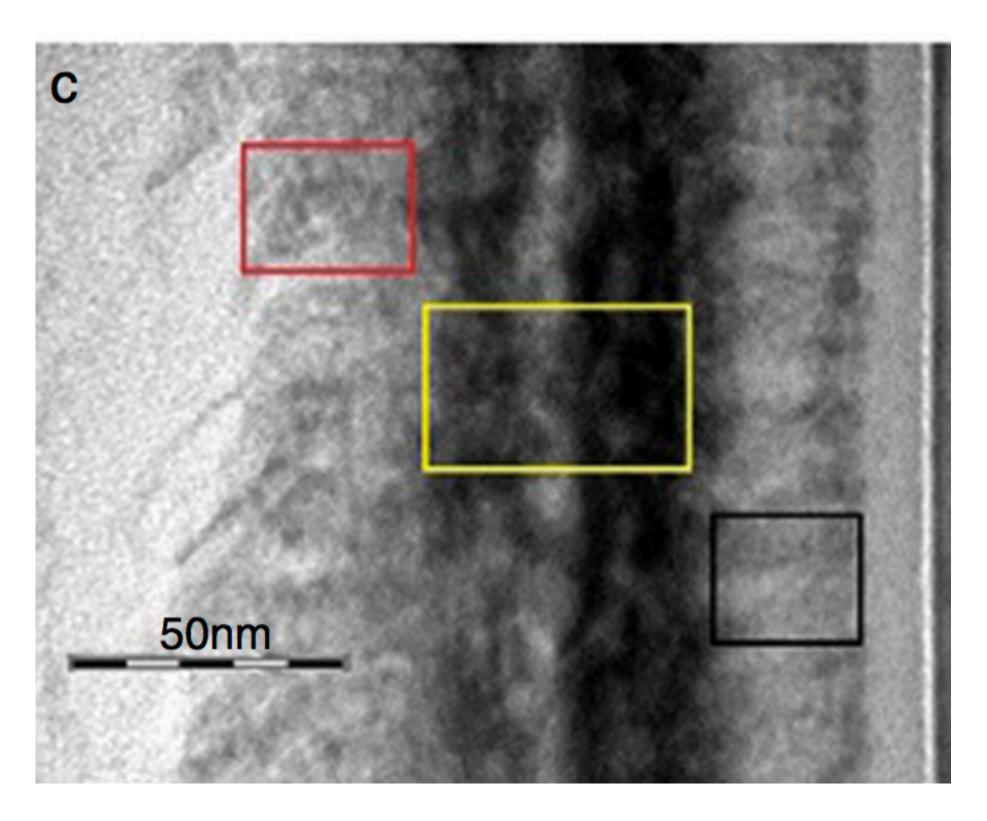


Ricardo Peterson Department of Electrical Engineering Extreme Environment Microsystems Lab (XLab) **Stanford University**

PI: Prof. Debbie Senesky Department of Aeronautics and Astronautics Department of Electrical Engineering (by Courtesy)

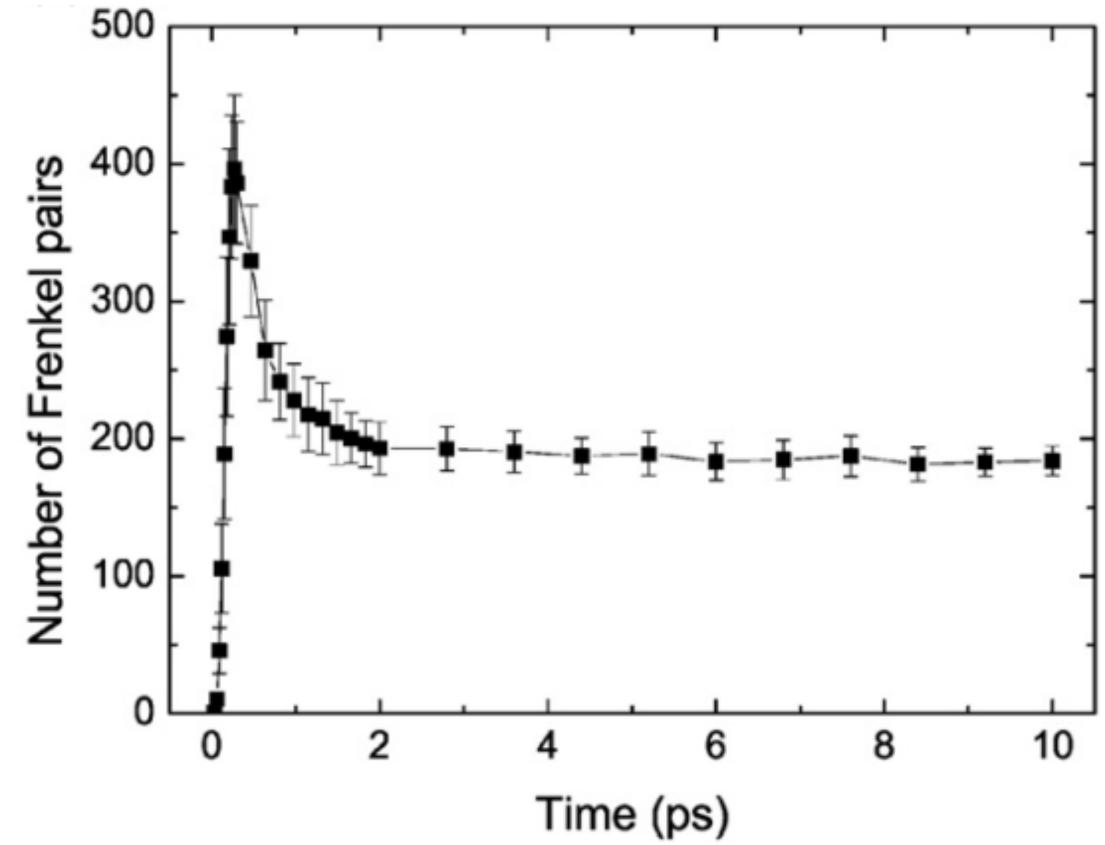


Irradiation-induced M-S Interface Degradation

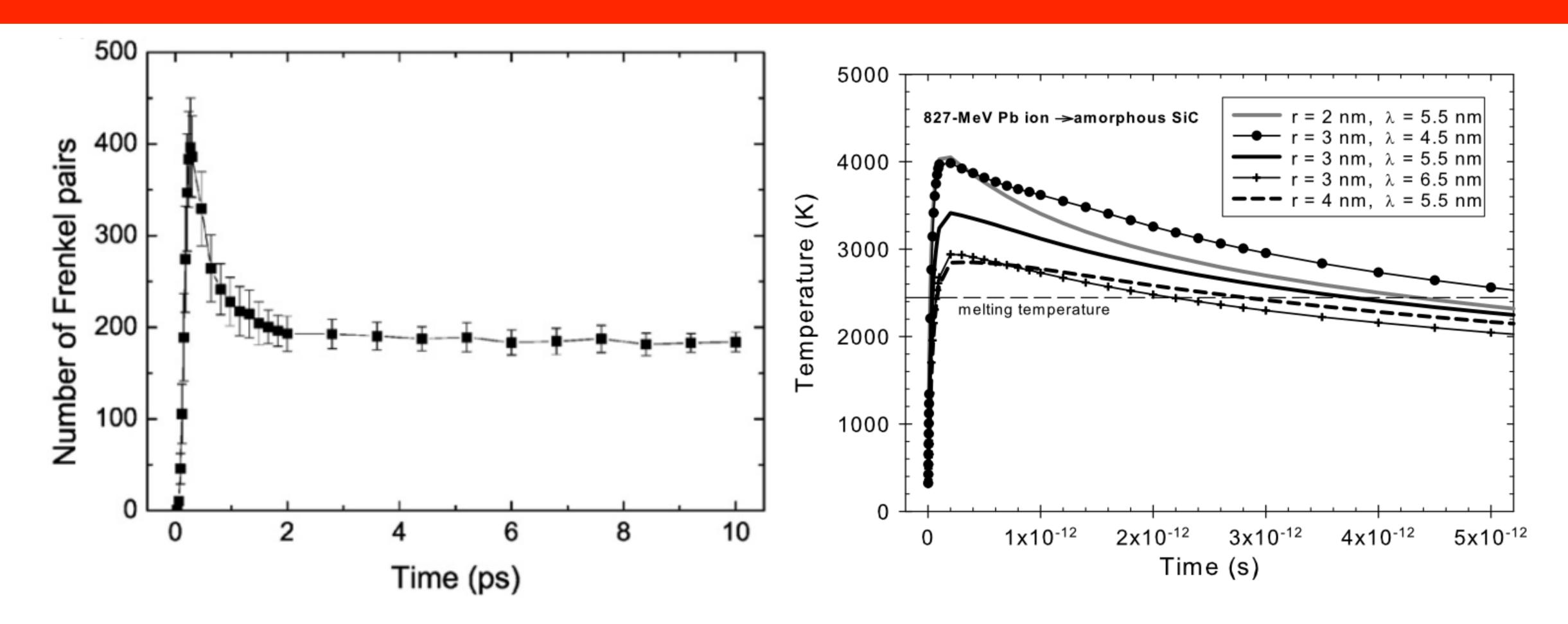


After 120MeV Au Irradiation

R. Verma, C. Lal, and I. Prabha, "Formation of metal silicide by swift heavy ion induced mixing at Mn / Si interface," Integr. Med. Res., vol. 3, no. 3, pp. 257–263, 2014.



Time Evolution of Defects Comparable Duration of Thermal Spikes

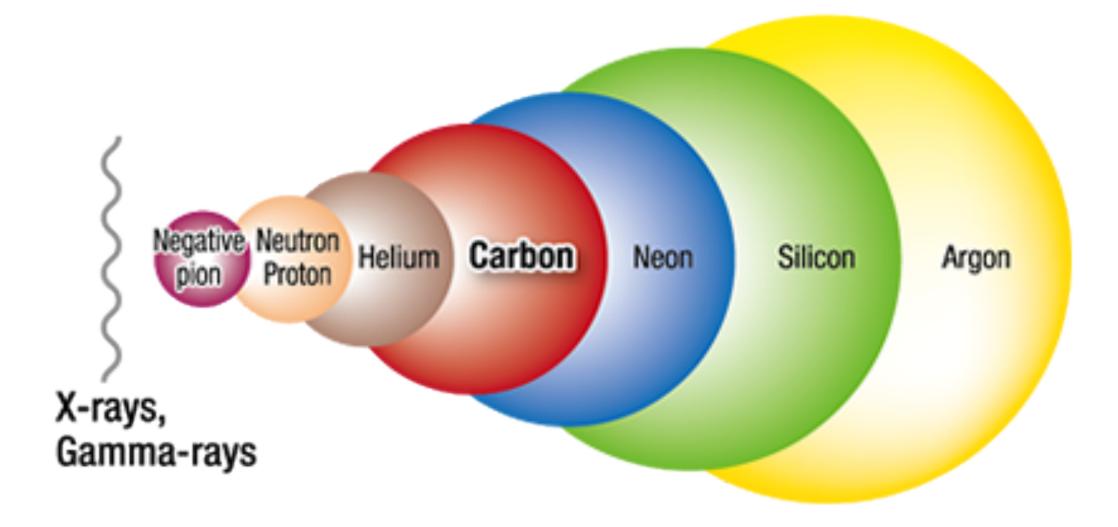


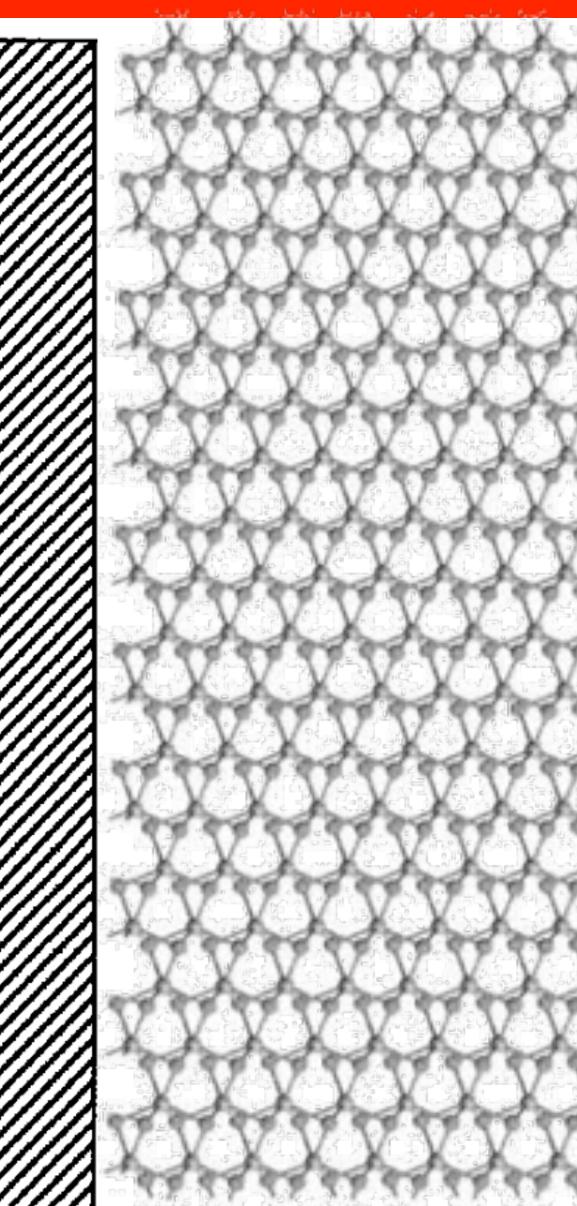
- Tang, D., Martin-Bragado, I., He, C., Zang, H., Xiong, C., Li, Y., ... Zhang, J. (2016). Time dependent modeling of single particle displacement damage in silicon devices. *Microelectronics Reliability*, 60, 25–32. http:// doi.org/10.1016/j.microrel.2016.03.004

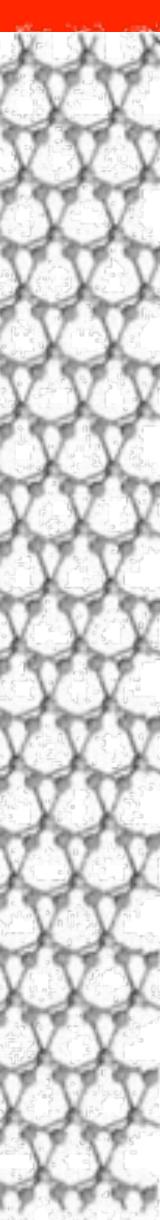
- A. Benyagoub, "Irradiation effects induced in silicon carbide by low and high energy ions," Nucl. Instruments Methods Phys. Res. Sect. B Beam Interact. with Mater. Atoms, vol. 266, no. 12–13, pp. 2766– 2771, 2008.



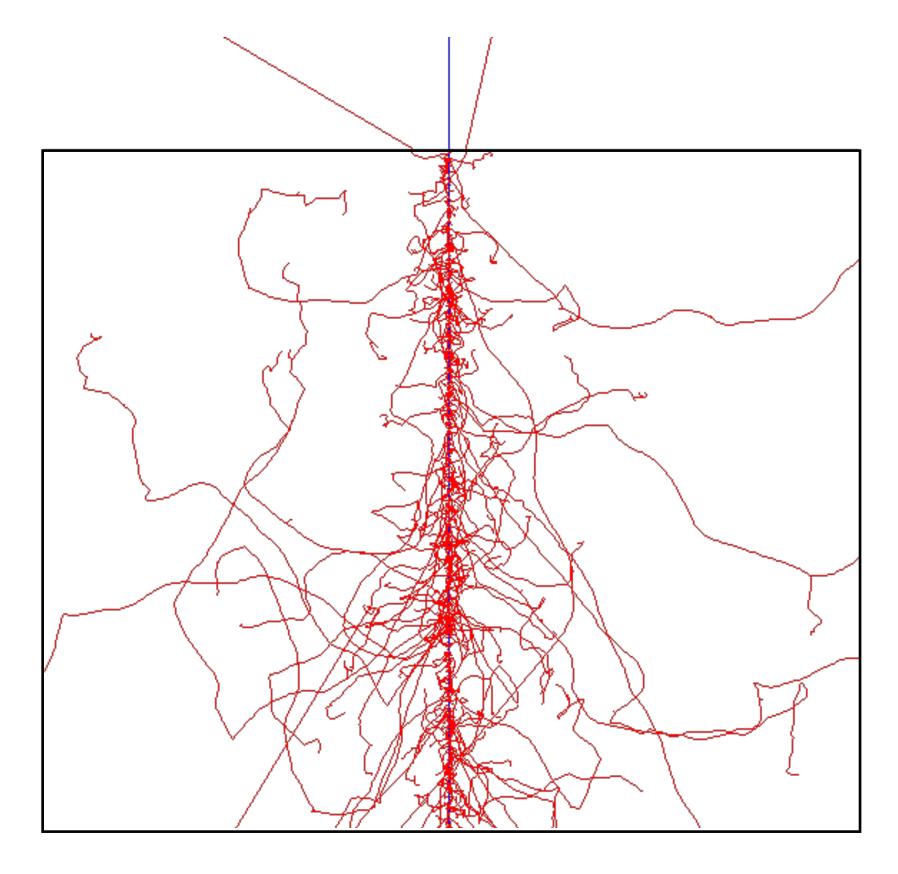
GOAL: To Simulate SETs and Thermal Spikes

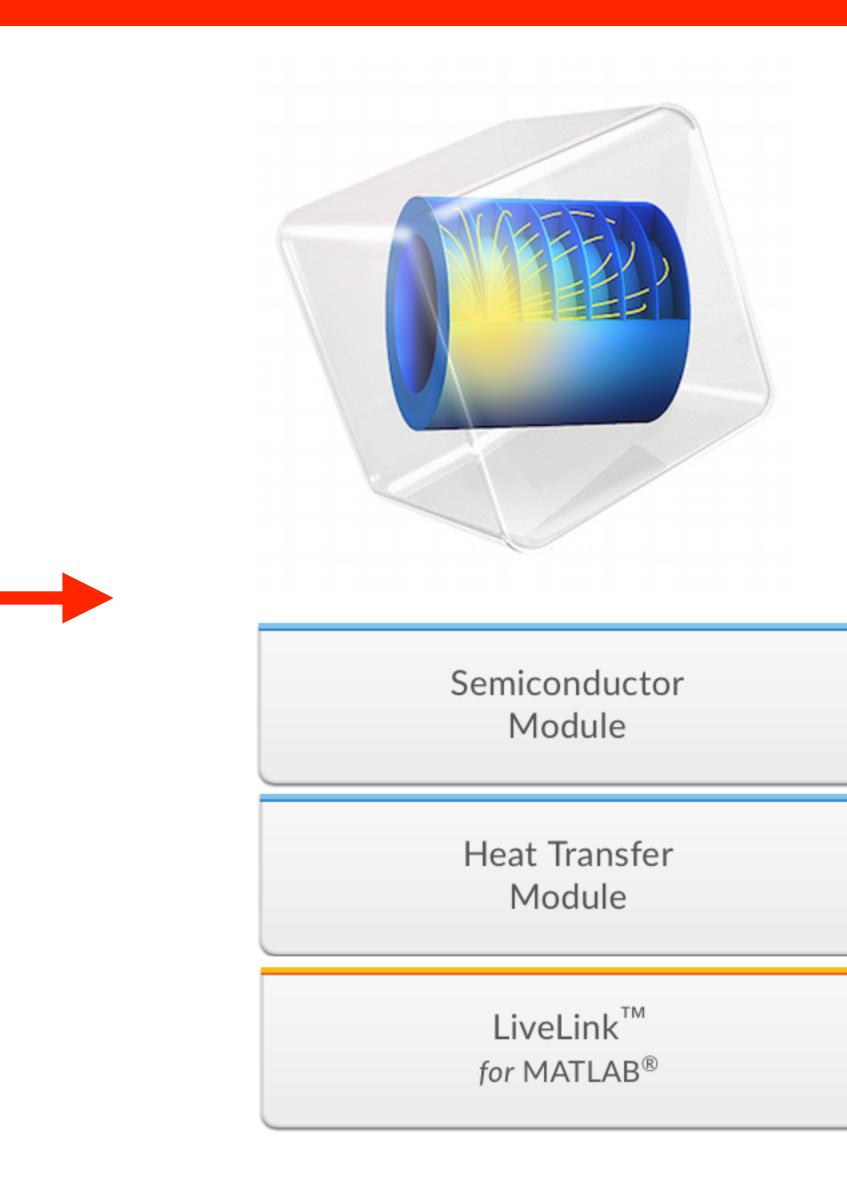




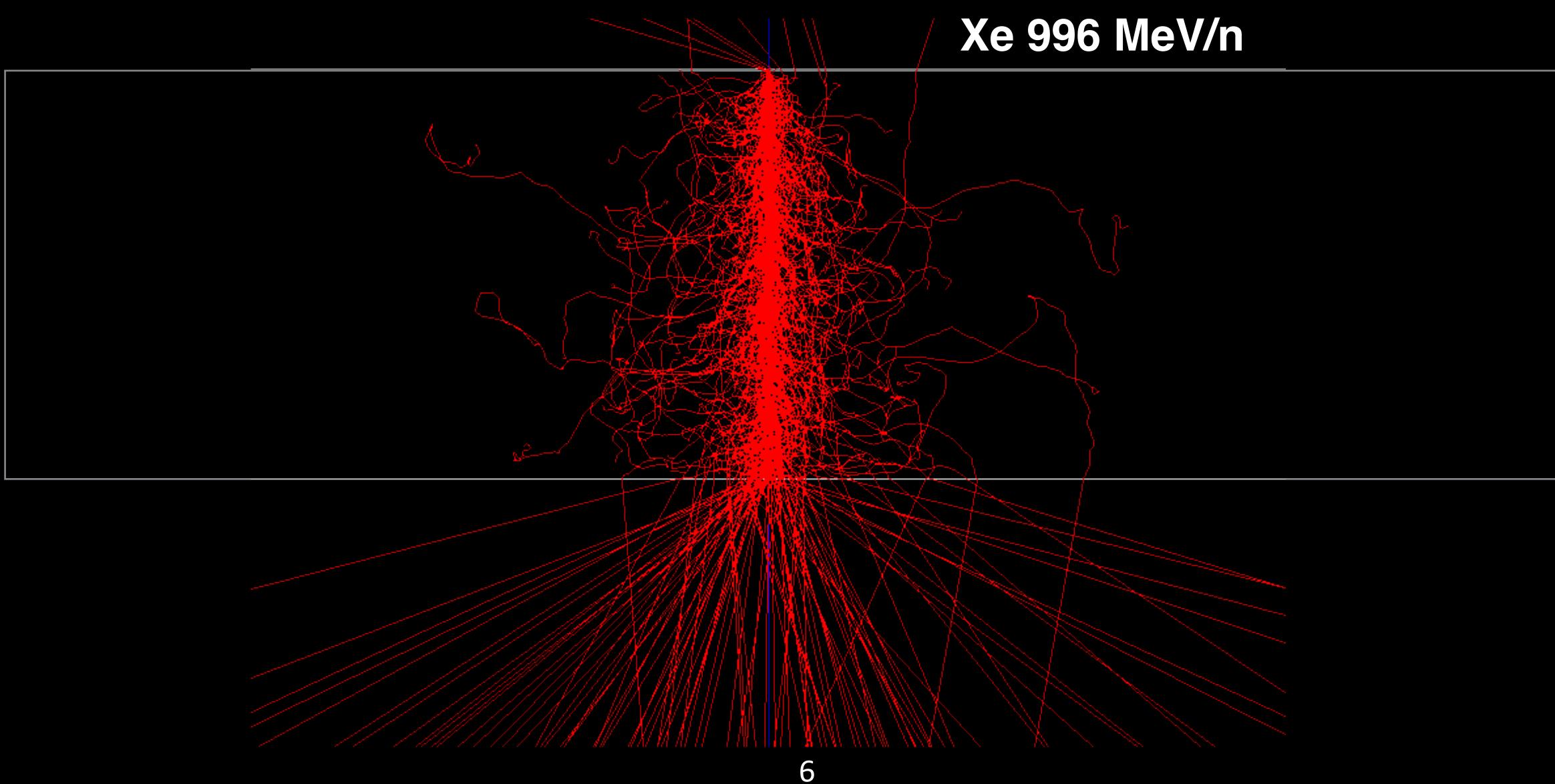


GEANT4 OUTPUT —> COMSOL





Example: 4H-SiC Schottky Diode





Example: 4H-SiC Schottky Diode

100 V (Ohmic Contact)

ND=1E16 cm-3



1um (Region Depleted)





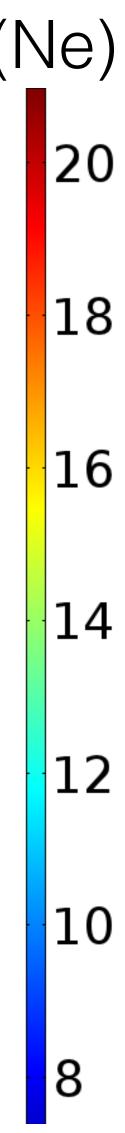
Xe 996 MeV/n

ND=1E16 cm-3

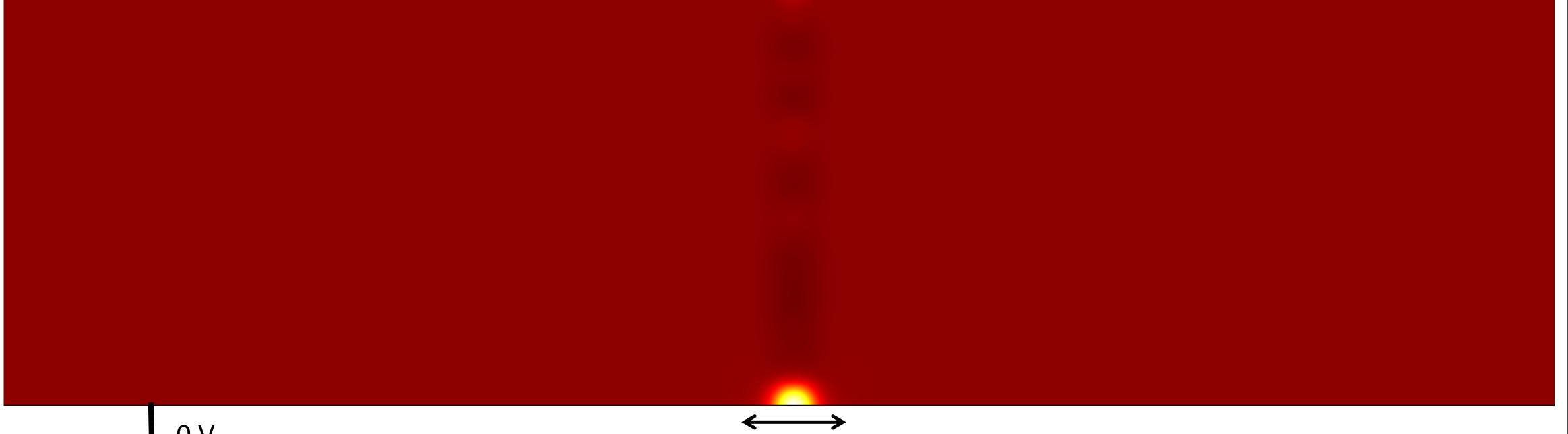


log10(Ne)





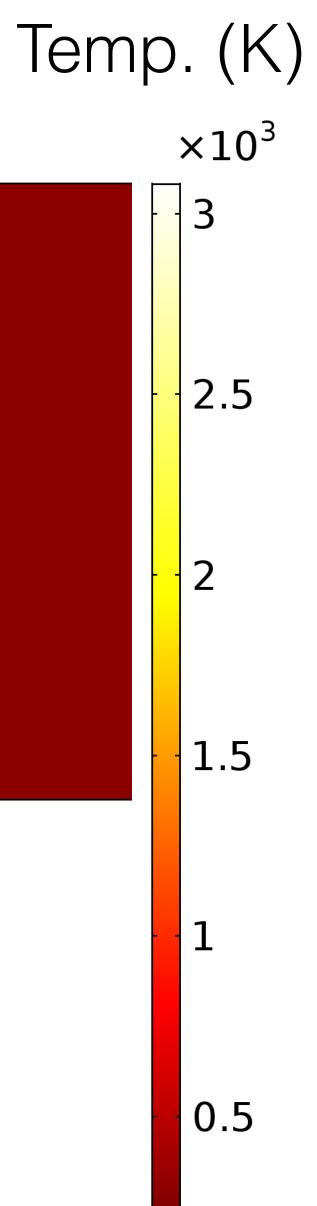


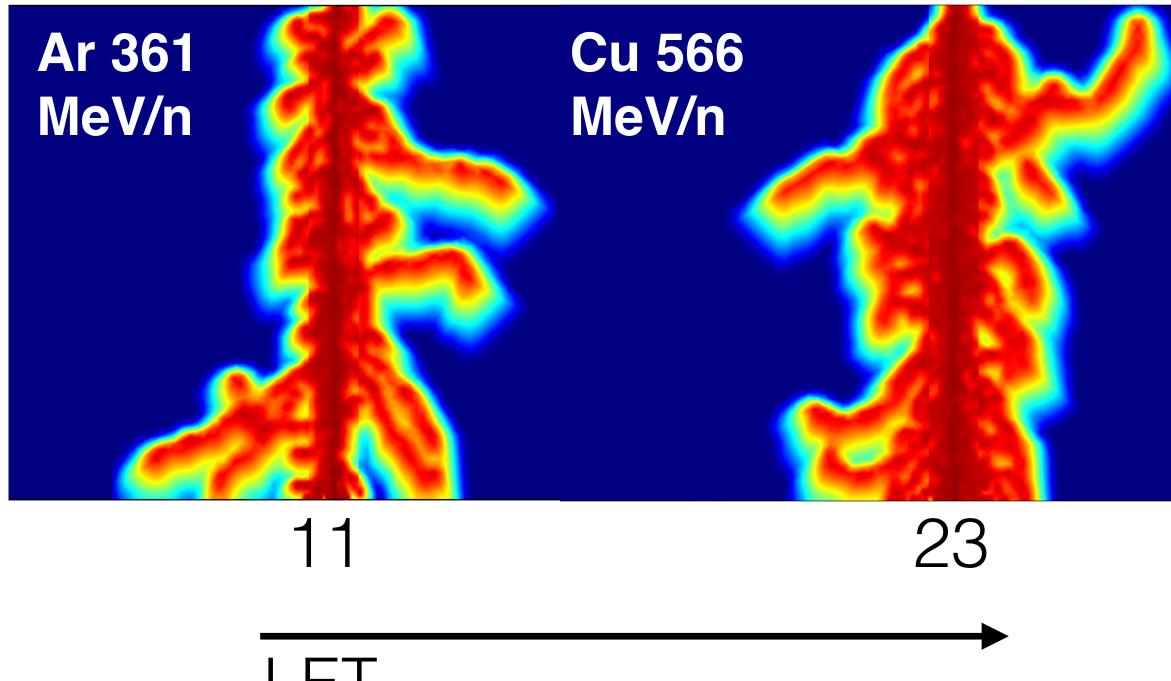




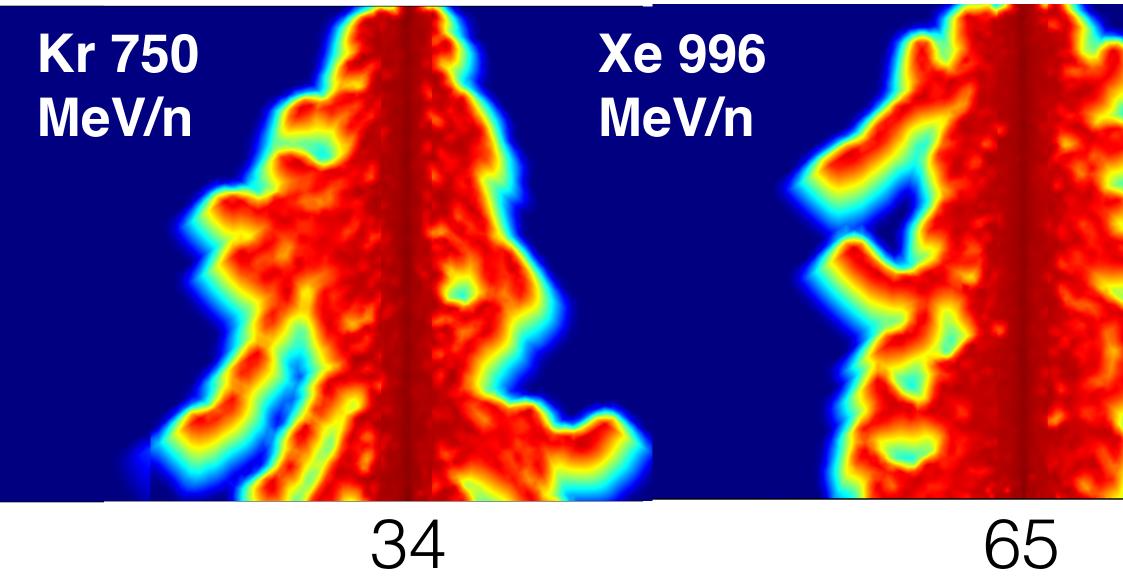


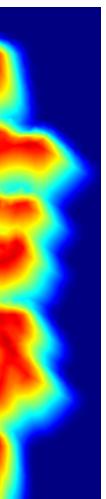
Temp. Distribution



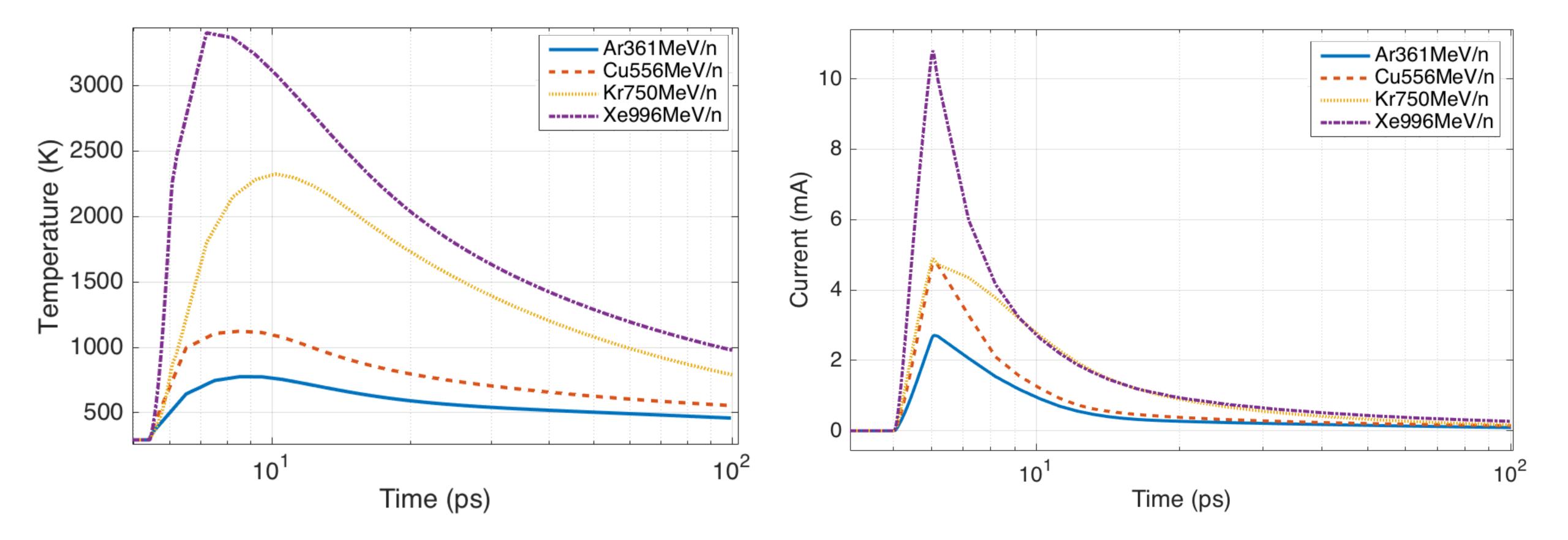


LET (MeV-cm2/mg)

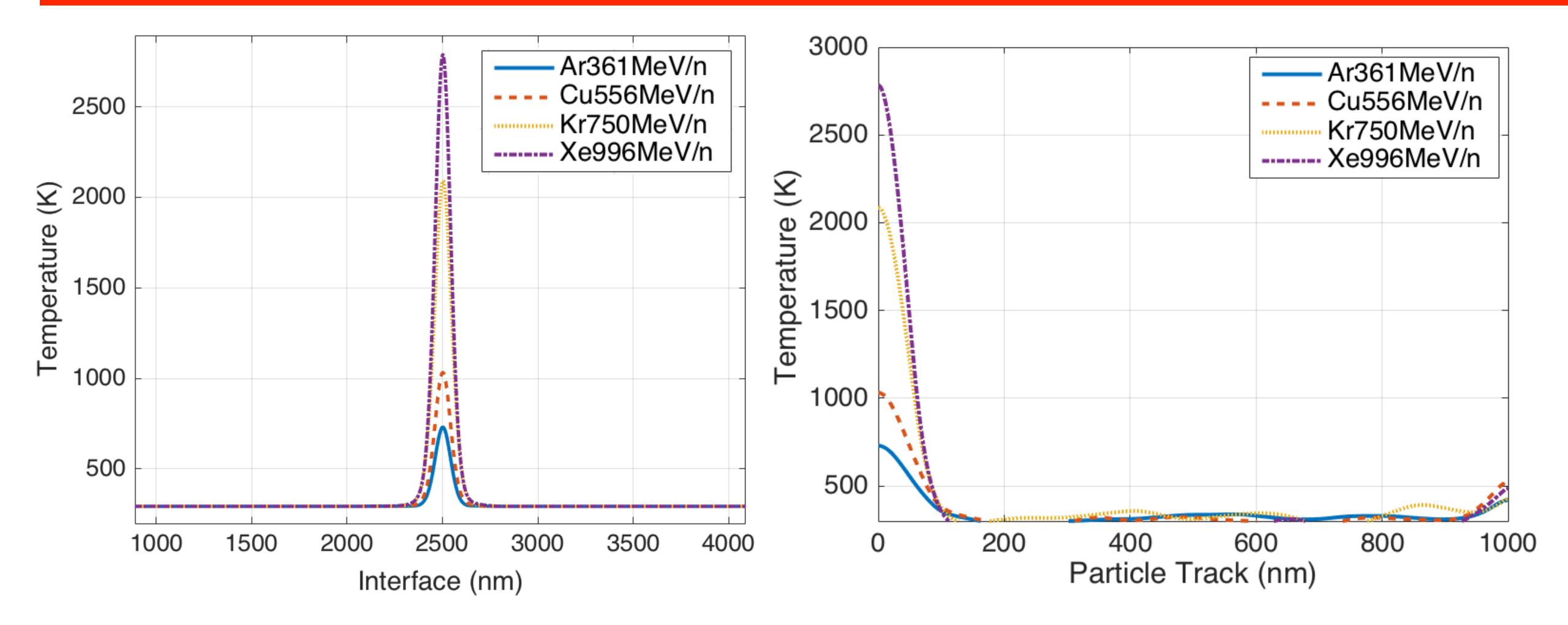




Current & Temperature vs. Time



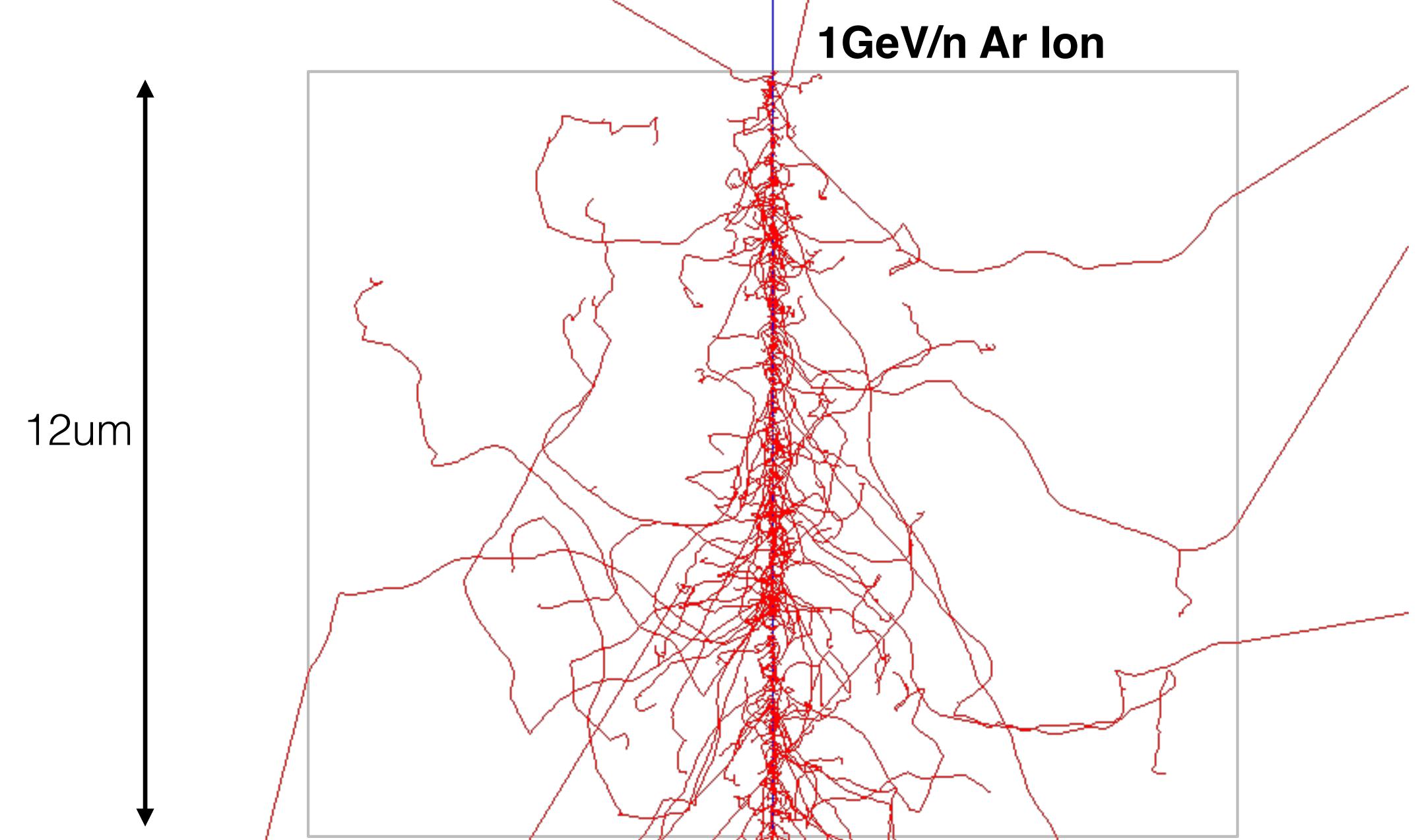
Temperature along Particle Track & Interface

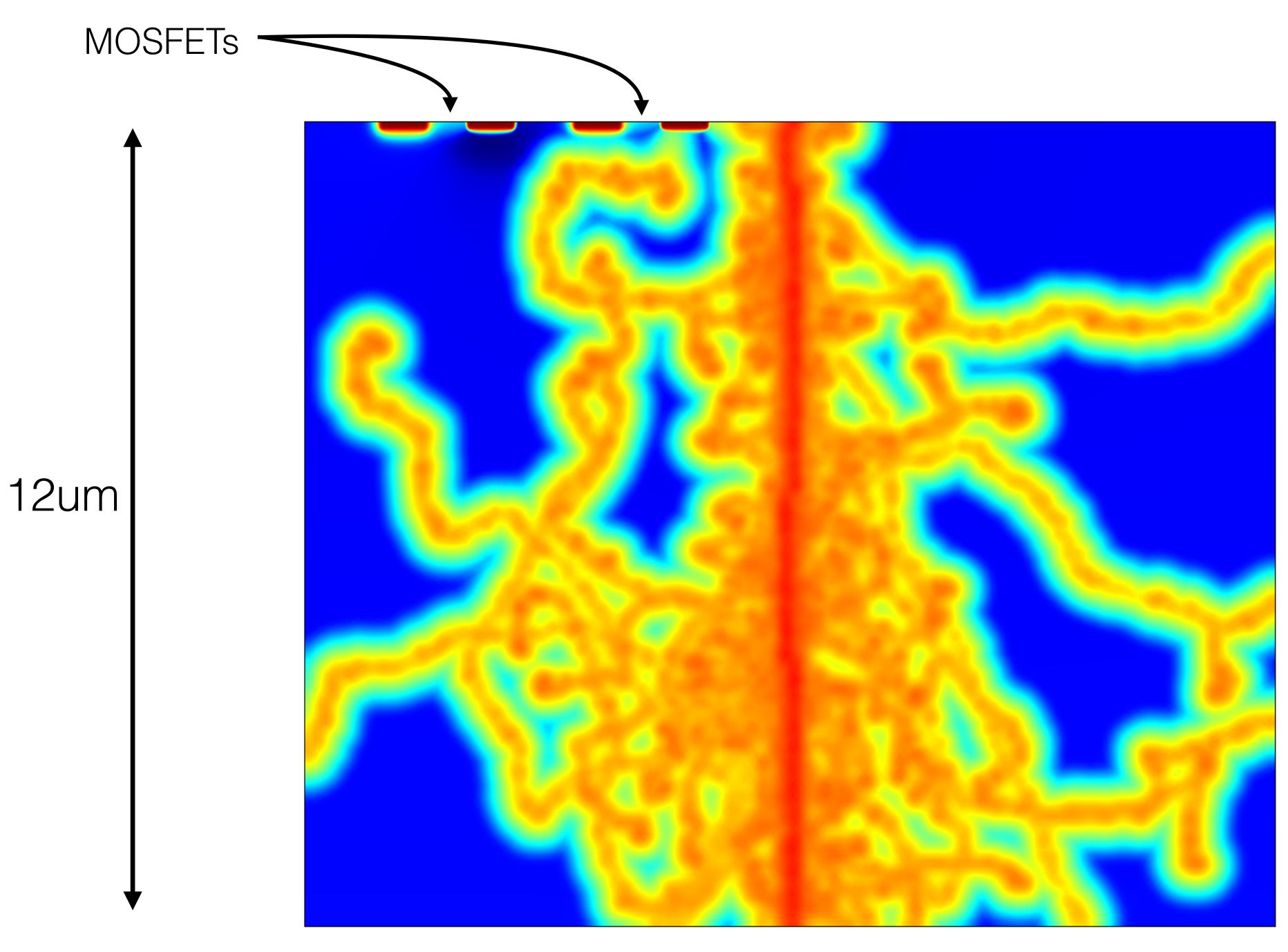


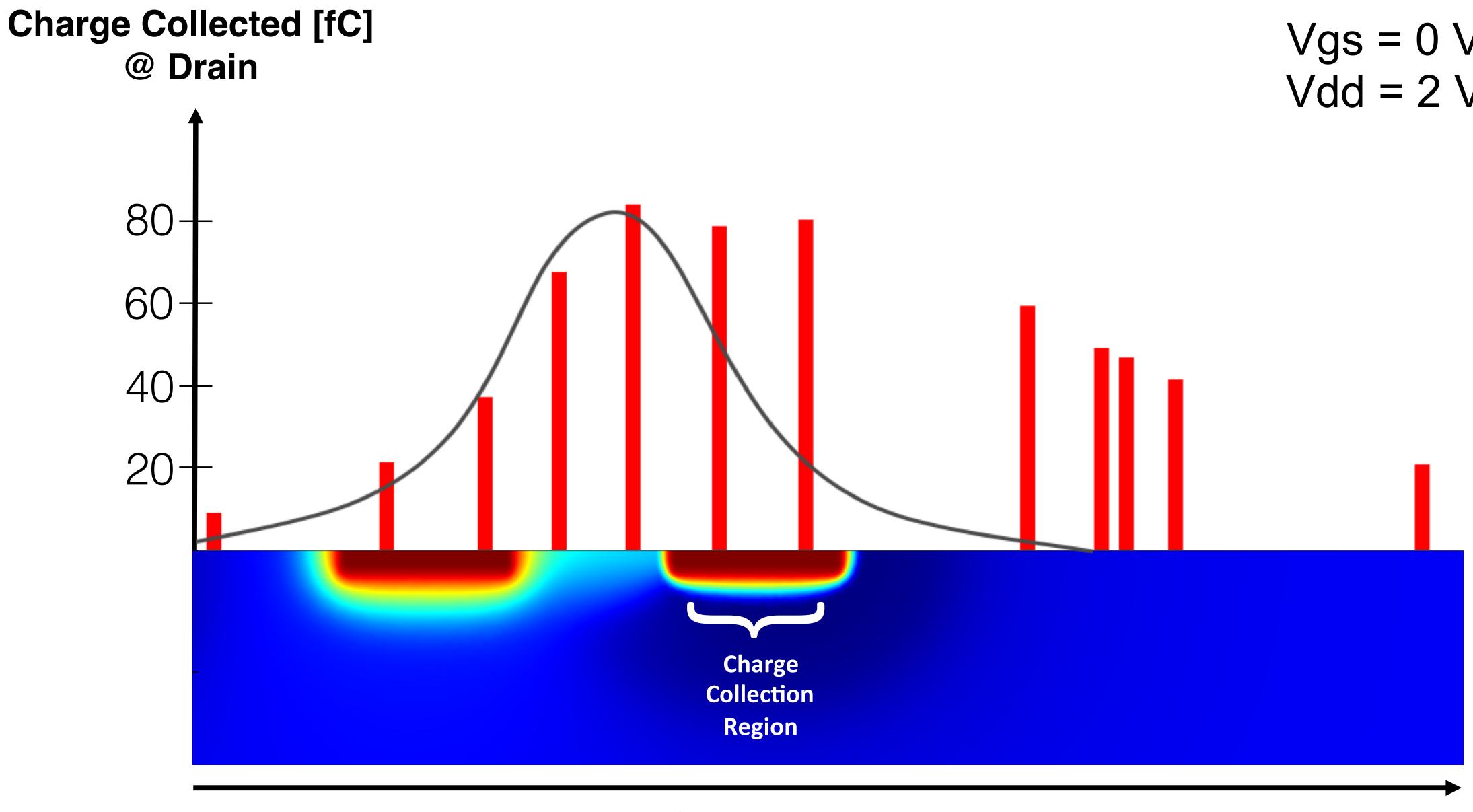
t ~ 10 ps



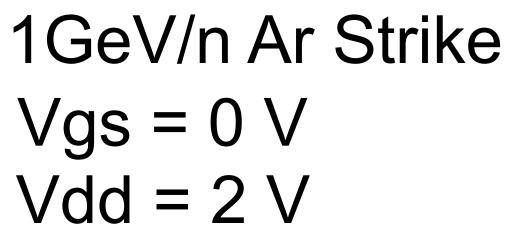
Extending Framework to Other Applications





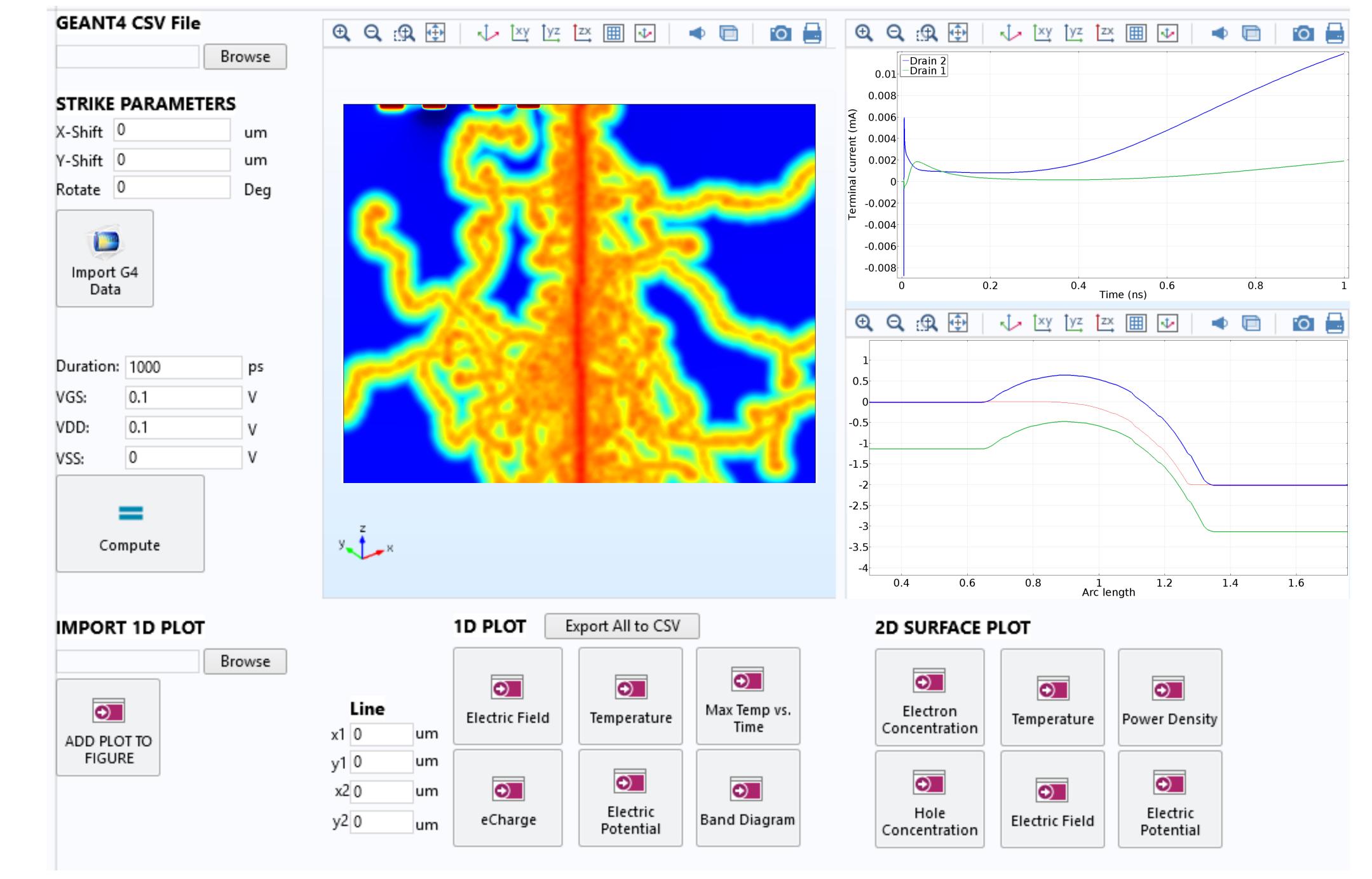


Particle Strike Location [um]





INTEGRATION WITH COMSOL'S APPLICATION BUILDER



Thank You